

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SICKLINGER, TODD	
		Examiner Vincent E. Kovalick	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,122,781	10-2006	Rotzoll et al.	250/221
*	B	US-6,847,350	01-2005	Van Brocklin et al.	345/157
*	C	US-6,701,296	03-2004	Kramer et al.	704/270
*	D	US-5,668,571	09-1997	Pai et al.	715/794
*	E	US-4,113,353	09-1978	Matsushita, Akira	359/636
*	F	US-3,949,391	04-1976	Benjamin, O'Connell Julien	345/182
*	G	US-2004/0239629	12-2004	Koo, James Y.	345/163
*	H	US-2004/0155853	08-2004	Lin, Yung-Lin	345/102
*	I	US-2003/0214481	11-2003	Xiong, Yongming	345/157
*	J	US-2003/0118391	06-2003	Adams, Guy de Warrenne Bruce	401/116
*	K	US-2003/0117370	06-2003	Van Brocklin et al.	345/156
*	L	US-2003/0020947	01-2003	Brewster et al.	358/1.15
*	M	US-4,922,236	05-1990	Heady, Richard	345/166

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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